

Search Notes

Application/Control No.

10/811,881

Examiner

Thomas D. Lee

Applicant(s)/Patent under
Reexamination

NAKABAYSHI ET AL.

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
358	1.1, 1.2, 1.9, 2.1, 443, 444	8/31/2006	TDL
358	448	8/31/2006	TDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR